



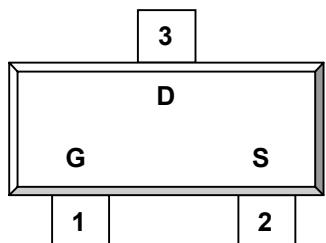
ST2304 
N Channel Enhancement Mode MOSFET

3.2A

DESCRIPTION

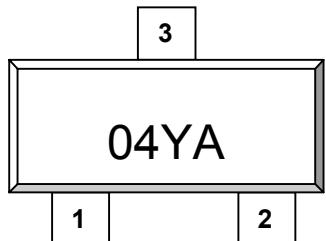
ST2304 is the N-Channel logic enhancement mode power field effect transistor which is produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management, other battery powered circuits, and low in-line power loss are required. The product is in a very small outline surface mount package.

PIN CONFIGURATION SOT-23-3L



1.Gate 2.Source 3.Drain

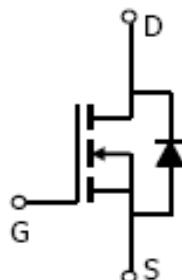
PART MARKING SOT-23-3L



Y: Year Code A: Process Code

FEATURE

- 30V/3.2A, $R_{DS(ON)} = 50\text{m-ohm}$ (Typ.) @ $VGS = 4.5\text{V}$
- 30V/2.0A, $R_{DS(ON)} = 65\text{m-ohm}$ @ $VGS = 2.5\text{V}$
- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability
- SOT-23-3L package design





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ABSOLUTE MAXIMUM RATINGS (Ta = 25°C Unless otherwise noted)

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	V _{DSS}	30	V
Gate-Source Voltage	V _{GSS}	±20	V
Continuous Drain Current TJ=150°C)	I _D	3.2 2.6	A
Pulsed Drain Current	I _{DM}	10	A
Continuous Source Current (Diode Conduction)	I _S	1.25	A
Power Dissipation	P _D	1.25 0.8	W
Operation Junction Temperature	T _J	150	°C
Storage Temperature Range	T _{STG}	-55/150	°C
Thermal Resistance-Junction to Ambient	R _{θJA}	100	°C/W



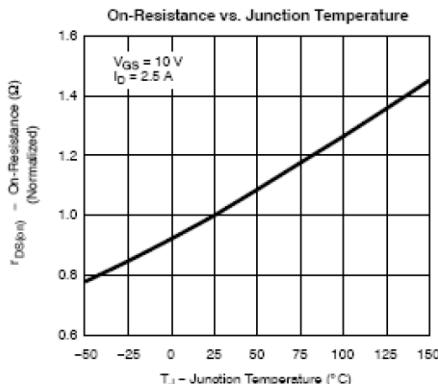
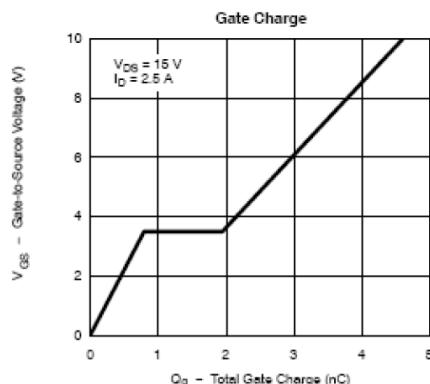
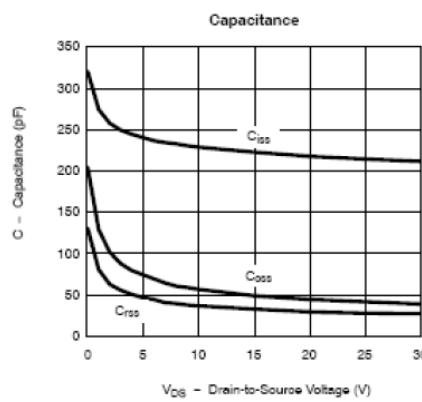
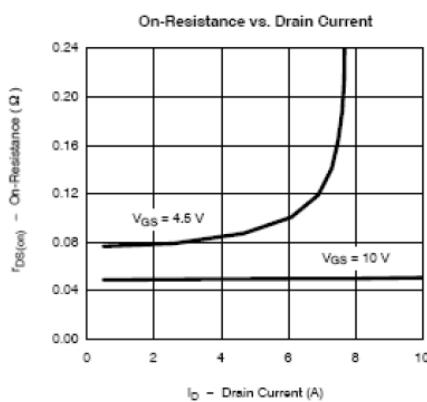
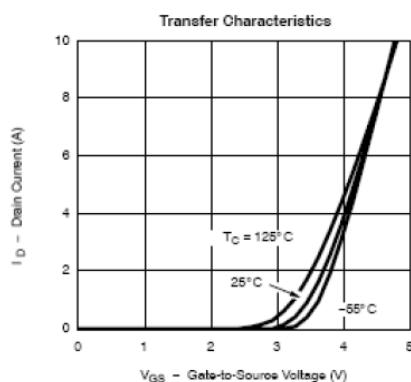
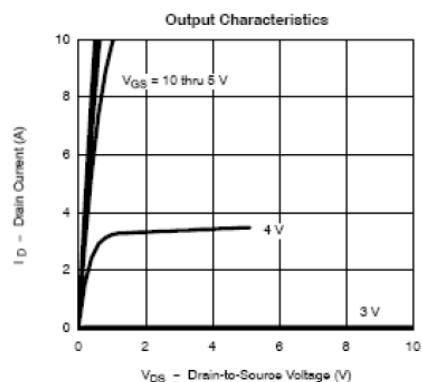
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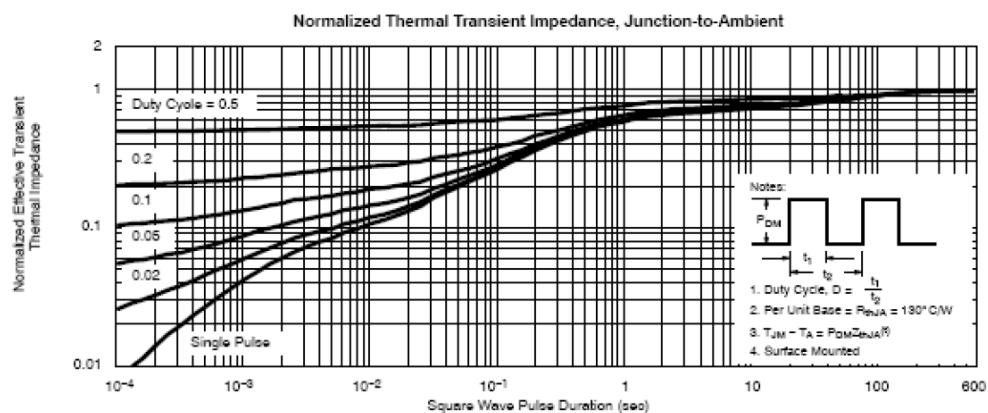
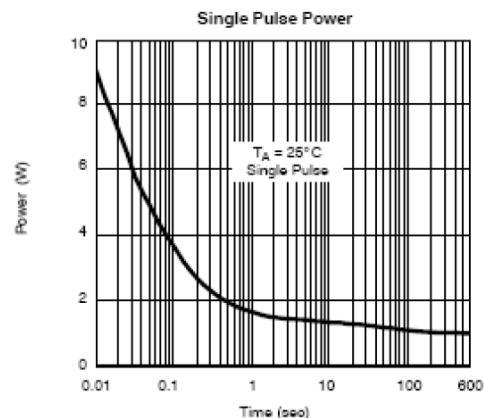
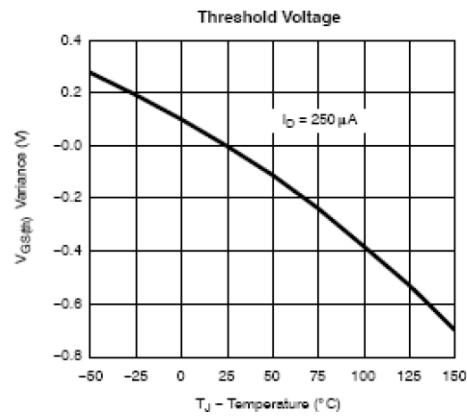
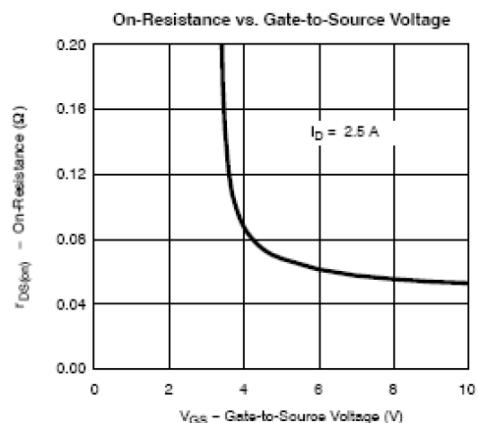
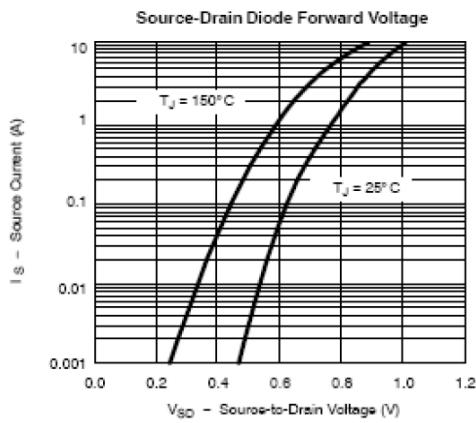
ELECTRICAL CHARACTERISTICS (Ta = 25°C Unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =250uA	30			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	1.0		2.5	V
Gate Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =±20V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =1.0V			1	uA
		V _{DS} =30V, V _{GS} =0V T _J =55°C			10	
Drain-source On-Resistance	R _{DSS(on)}	V _{GS} =10V, I _D =3.2A V _{GS} =4.5V, I _D =2.0A	0.050 0.065	0.058 0.075		Ω
Forward Transconductance	g _f	V _{DS} =4.5V, I _D =2.5V		4.6		S
Diode Forward Voltage	V _{SD}	I _S =1.25A, V _{GS} =0V		0.82	1.0	V
Dynamic						
Total Gate Charge	Q _g	V _{DS} =15V V _{GS} =10V I _D =2.5A		4.5	10	nC
Gate-Source Charge	Q _{gs}			0.8		
Gate-Drain Charge	Q _{gd}			1.0		
Input Capacitance	C _{iss}	V _{DS} =15V V _{GS} =0V F=1MHz		240		pF
Output Capacitance	C _{oss}			110		
Reverse Transfer Capacitance	C _{rss}			17		
Turn-On Time	t _{d(on)} tr	V _{DD} =15V R _L =15Ω I _D =1.0A V _{GEN} =10V R _G =6Ω		8.0	20	nS
Turn-Off Time	t _{d(off)} tf			12	30	
				17	35	
				8.0	20	

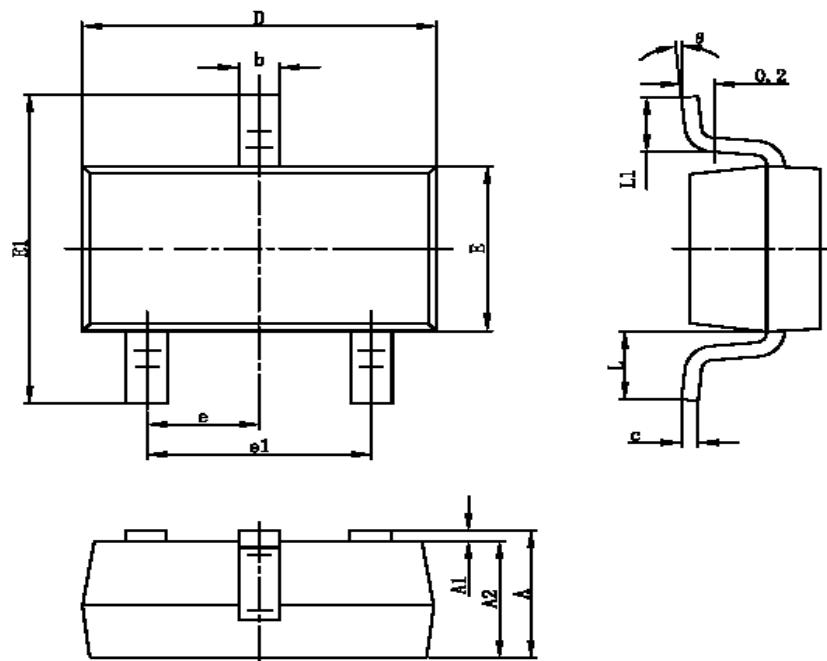
TYPICAL CHARACTERISTICS (25°C Unless noted)



TYPICAL CHARACTERISTICS (25°C Unless noted)



SOT-23-3L PACKAGE OUTLINE



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.400	0.012	0.016
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
e	0.950TYP		0.037TYP	
e1	1.800	2.000	0.071	0.079
L	0.700REF		0.028REF	
L1	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°